

<b>Notice of References Cited</b>	Application/Control No. 10/749,354		Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner Christopher D. Koharski		Art Unit 3763	Page 1 of 1

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*	A	US-2002/0002349	01-2002	Flaherty et al.	604/164.11
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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